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Applicant(s): Wayne G. Renken
Title: Process Condition Sensing Wafer and Data Analysis System
Application No.: 10/056,906 Filing Date: January 24, 2002
Examiner: Charles D. Garber Group Art Unit: 2856
Docket No.: SENS.005US0 Conf. No.: 2359

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

07/15/2004 SSESHE1 00000035 502664 10056906
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INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Pursuant to 37 C.F.R. §§ 1.56, 1.97 and 1.98, Applicant(s) call(s) the documents listed on the enclosed Form PTO-1449 to the Examiner's attention in this patent application..

Copies of the documents listed on the accompanying Form PTO-1449 are enclosed.

Citation of these documents shall not be construed as (1) an admission that the documents are prior art with respect to the invention or inventions claimed in this application, (2) a representation that a search has been made (other than as indicated by any cited document), or (3) an admission that the cited information is, or is considered to be, material to patentability as defined in § 1.56(b).

This information disclosure statement is submitted under 37 C.F.R. § 1.97(c). A check including \$180.00 for the information disclosure statement fee under 37 C.F.R. § 1.17(p), is enclosed. The Commissioner is authorized, however, to charge any fee that may be required, or to credit any overpayment, against Deposit Account No. 502664. This form is being submitted in duplicate.

Attorney Docket No.:
SENS.005US0

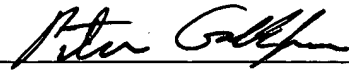
Application No.:
10/056,906

The PTO did not receive the following listed item(s) a check for \$180.00

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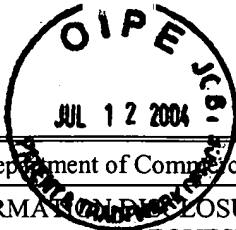
EV437667836US

Respectfully submitted,



Peter A. Gallagher
Reg. No.47,584

7/12/04
Date



U.S. Department of Commerce, Patent and Trademark	Atty. Docket No.	Application No.
INFORMATIONAL DISCLOSURE STATEMENT BY REQUESTOR	SENS.005US0	10/056,906
	Applicant(s)	Conf. No.
(Use several sheets if necessary)	Wayne G. Renken	2359
	Filing Date	Group
	January 24, 2002	2856

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U.S. Patent Documents

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate

U.S. Published Patent Application Documents

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	1	2002/0078770	Jun. 27, 2002	Hunter			

Foreign Patent Documents

							Translation	
		Document	Date	Country	Class	Subclass	Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner

Date Considered

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.